

**Search Notes**

Application/Control No.

09/922,945

Examiner

Minh Dieu Nguyen

Applicant(s)/Patent under  
Reexamination

FUKASAWA, MIKIO

Art Unit

2137

**SEARCHED**

Class	Subclass	Date	Examiner
726	26-27	12/15/2005	MDN
718	102-103	12/15/2005	MDN
709	224	12/15/2005	MDN
705	51-52	12/15/2005	MDN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	12/15/2005	MDN